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Shallow acceptor levels in Si/G e/Si quantum well heterostructures are characterized by resonant tunneling spectroscopy in the presence of high magnetic elds. In a perpendicular magnetic eld we observe a linear Zeem an splitting of the acceptor levels. In an in-plane eld, on the other hand, the Zeem an splitting is strongly suppressed. This anisotropic Zeem an splitting is shown to be a consequence of the huge light hole-heavy hole splitting caused by a large biaxial strain and a strong quantum con nem ent in the Ge quantum well.

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Spintronic and quantum com puting [1,2] are novel device concepts relying on quantum mechanical coherence. Si/Ge-based systems are promising candidates o ering long spin coherence times [3, 4], fast operations, and a well-established record of scalable integration. These im portant properties are also crucial requirem ents [2, 5, 6] for in plem enting multi-qubit operations in a future quantum computer. One concept that may form the technological basis of a quantum computer is the spin-resonance transistor (SRT) [7]. Vrijen et. al. [8] proposed an SRT where the electron spin manipulation is realized using the change in g-factor between Si-rich and Ge-rich environments of a Si/Geheterostructure. However, engineering the q-factor in such systems is complicated by the fact that the electron states in Siare in the X valleys whereas in Ge the electrons are located in the L valleys [9]. This problem does not arise for the valence band states, as both Si and Ge have their valence band maximum at the point. Thus, valence band states in Si/Ge are a promising choice for g-factor engineering in search for spin manipulation.

In this paper we have analyzed the g-factor of shallow acceptor levels in a Si/G e-heterostructure by resonanttunneling spectroscopy. We nd that their e ective g-factor is highly anisotropic, giving a large Zeem an splitting of the acceptor states in a perpendicular eld, whereas we cannot resolve any Zeem an splitting in inplane elds up to 18 T. This giant anisotropy provides the possibility to tune the coupling of the holes to an external magnetic eld by a gate-controlled shift of the hole wave function [10] in spintronic devices.

For a proper understanding of acceptor levels it is essential to take into account the fourfold degeneracy of the valence band at the point (Fig. 1) which rejects the fact that the bulk valence band edge in these materials is characterized by an ejective angular momentum J = 3=2 [11, 12]. As the symmetry of the crystal is reduced due to biaxial strain and a conneminent potential, the degenerate states split into heavy-hole (HH) subbands with $J_z = 3=2$ and light-hole (LH) subbands with $J_z = 1=2$. Here, the quantization axis for the angular

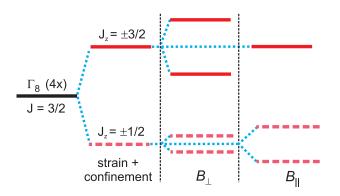


FIG.1: Qualitative sketch of the valence band states at di erent perturbation conditions. A lready at B = 0, biaxial strain and a con nem ent potential reduce the fourfold degeneracy to twofold, giving heavy-hole (HH) states with $J_z = 3=2$ and light-hole (LH) states with $J_z = 1=2$. Depending on the orientation of the magnetic eld, the twofold degeneracies of the HH and LH states will be lifted or preserved.

momentum is the z-axis perpendicular to the epitaxial layer. So both parameters, the con nement potential and the built-in strain, substantially in uence the energy levels of an acceptor in a quantum well (QW) [13, 14]. In a magnetic eld B? orientated perpendicular to the epitaxial layer we get a Zeem an splitting of HH and LH states, $E_{HH(LH)}^{?} = g_{HH(LH)}^{?} B_{?}$, where $g_{HH(LH)}^{?}$ is the g-factor of the HH (LH) states in a perpendicular eld and B is the Bohrm agneton. But for an in-plane m agnetic eld B_k the linear Zeem an splitting of H H states is suppressed because there is no B k -induced direct coupling between these states, hHHjJ B, jHHi = 0, where J is the vector of J = 3=2 spin m atrices [15, 16, 17, 18]. This does not apply for LH states which show a significant Zem an splitting $E_{LH}^k > 0$. We emphasize that the vanishing Zeem an splitting of HH states in a parallel eld re ects the fact that the HH-LH splitting in our sam ples is much larger than the maxim al Zeem an energies (7 m eV) [12].

Figure 2 shows the layer sequence and the valence band pro le of our samples. They are prepared by growing a

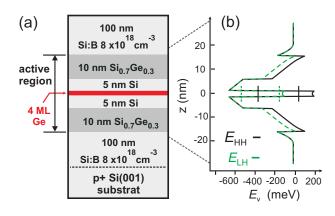


FIG.2: (a) Layer sequence of the heterostructure. (b) Selfconsistently calculated valence band pro le of the active region. The solid line shows the shape of the heavy-hole (HH) subband and the dashed line the light-hole (LH) subband. Due to biaxial strain and a strong quantum con nement a huge HH-LH splitting results.

100 nm thick SiB layer (p = 8 10^{18} cm 3) on a (001) p⁺-Sisubstrate. The active region of the sam ples consists of two 10 nm thick SiG eQW s separated by a 10 nm thick Sibarrier. In the center of the Sibarrier a 4 m onolayers (ML) thick GeQW is embedded. Finally, the active region is capped with 100 nm SiB (p = 8 10^{18} cm 3). For the dc-transport m easurem ents we have fabricated diodes with lateral diam eters of 1 m. M easurem ents we re perform ed at tem peratures down to T = 50 mK and using m agnetic elds up to 18 T.

Figure 3 (a) shows a typical current-voltage (I V) characteristic of a diode at T = 50 m K . A staircase structure is observed that is even better resolved in the differential conductance (dI=dV) curve shown in Fig. 3 (b). The steplike increase of the current is in a bias range which is about 300 m V below the onset of resonant tunneling of holes through the 2D subbands of the current steps. W e attribute these current steps in the pA-range to tunneling processes of holes through zero-dim ensional acceptor levels of B oron dopant-atom s which have m igrated into the G e Q W from the highly doped SiB contact regions.

A resonant tunneling process through an acceptor level E_s occurs each time E_s is in resonance with the Ferm i energy E_F of the emitter. The bias position of a current step is given by $V_s = (E_s \quad E_F) = e$, where is the bias-to-energy conversion coe cient. We determ ine from the tem perature-dependent broadening of the current step edges. As a measure of this broadening, we use the full width at halfmaximum of the corresponding di erential conductance peaks, V_s [see Fig. 3(b)]. It increases according to ($e V_s)^2 = (E_s)^2 + (3:53 \text{ kT})^2$, where the term 3:53 kT stems from the broadening of the Ferm ifunction characterizing the carrier distribution. U sing this equation we obtain = 0.5 0:1 for several

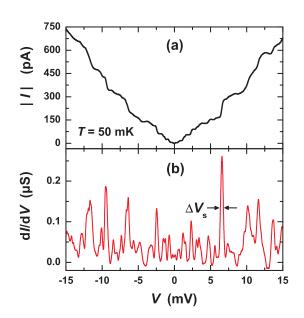


FIG.3: (a) Current{voltage (I V) characteristics of a diode with a diam eter of 1 m at T = 50 mK and (b) the corresponding di erential conductance (dI=dV). A current step respectively a di erential conductance peak occurs whenever resonant tunneling through a shallow acceptor level in the G e quantum well is energetically possible.

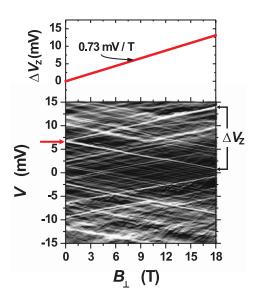


FIG. 4: Gray-scale plot of the di erential conductance at 50 mK for a magnetic eld orientated perpendicular to the epitaxial layer, where a dark (bright) shade corresponds to sm all (large) conductance. Exem plarily, the top graph shows the splitting of a level, marked by an arrow at 6.5 mV.

peaks in both bias polarities.

Figure 4 shows a gray-scale plot of the di erential conductance dI=dV as a function of an external magnetic

eld orientated perpendicular to the epitaxial layer, B_7 . In the voltage range from 15 mV to 15 mV the conductance maxim a exhibit a linear splitting as a function of

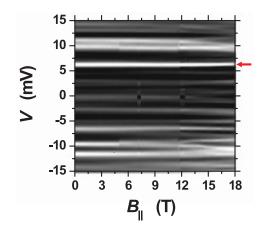


FIG.5: G ray-scale plot of the di erential conductance at 1 K for a magnetic eld orientated parallel to the epitaxial layer, where a dark (bright) shade corresponds to sm all (large) conductance. The right arrow points to the same level as in Fig.4.

 $B_{\,2}$. All levels show accurately the same splitting, as indicated by the parallelevolution of the conductance m axim a. As an example, the upper panel of Fig. 4 shows the splitting of the conductance maximum at 6.5 mV. The gradient of the splitting isd $V_{\rm Z}$ =dB $_2$ = 0:73 mV/T.W e attribute the linear splitting to the Zeem an splitting of the HH sublevels, $E_{\rm Z}$ = $g_{\rm H\,H}^2$ $_{\rm B}\,B_2$. The g-factor $g_{\rm H\,H}^2$ can be determined using

$$g_{H_{H}}^{2} = \frac{e}{B_{B}} \frac{dV_{Z}}{dB_{2}} : \qquad (1)$$

W ith = 0.5 and d $V_z=dB_2$ = 0.73 mV/T we obtain $g_{H\,H}^2$ = 6.3. This value agrees well with optically measured g-factors [19, 20] of group-III in purities such as B in Ge. This con rm s the assumption that the observed levels belong to B oron dopant-atom s which have di used from the heavily doped contact regions into the GeQW.

Using the B₂ dependence of the conductance we can obtain an upper limit for the radial extent of the wave function of a hole bound to an acceptor level. According to rst-order perturbation theory, a ground state acceptor level is a ected by a diam agnetic shift E_D ' $e^2B_2^2$ '=8m , with m $0.28m_0$ the HH effective mass of Ge. (We neglect here the modi cations of the hole wave functions caused by the con nem ent in the narrow QW .) But even at $B_{?} = 18$ T a diam agnetic shift of the levels cannot be observed in our measurements, only the contribution of the linear Zeeman splitting can be seen in Fig. 4. This in plies that the diam agnetic shift E_D of the acceptor level is smaller than the width E_s ' 0:15 m eV of the conductance peak at 50 mK so that must be smaller than 2:5 nm. Therefore, of the acceptor wave functions in the thin GeQW is of the same order as the QW width. We remark that Bastard [21] derived a simple model to estimate for an

in purity in a narrow QW which yields for our system parameters $0.3a_B$, where $a_B' 3.1$ nm is the elective Bohr radius for heavy holes in Ge.

Next we present in Fig. 5 our results for the measured conductance in an in-plane magnetic eld B_k . W hile we saw in Fig. 4 that B_2 gives rise to a signi cant Zeem an splitting of the acceptor levels linear in B_2 , it is most remarkable that up to 18 T most conductance maxim a are not at all in uenced by an in-plane magnetic eld B_k . The conductance maximum at 6.5 mV, which exhibits a pronounced linear splitting for B_2 (arrow in Fig.4), does not show any splitting in the case of an in-plane magnetic eld B_k (arrow in Fig.5). If a splitting exists, it must be sm aller than the width of the conductance peak which is about 0.35 m eV [22] here.

The giant anisotropy of the Zeem an splitting is a consequence of the e ective spin J = 3=2 of the valence band states (Fig. 1). For a detailed interpretation of our experimental results, we have performed self-consistent calculations in the multiband envelope-function approximation [12] of the valence band prole of the active region using the nom inal grow th parameters. The results of the calculation are plotted in Fig. 2 (b). The solid (dashed) lines show the HH (LH) subbands and the strain-split e ective potentials for these states. The calculation predicts a splitting of the lowest HH and LH subbands of about 200 m eV. This huge HH-LH splitting is caused by the strong quantum con nem ent of the thin G e layer and the large biaxial strain due to the lattice m ism atch between G e and Si.

The behavior of the HH states in our device is in sharp contrast to electron states for which it is well-known that the Zeem an splitting is proportional to the totalm agnetic

eld B irrespective of the orientation of B relative to the epitaxial layer. Furtherm ore, con nem ent potential and strain do not a ect the Zeem an energy of electron states. In the case of H H states, on the other hand, the Zeem an splitting in a eld B_k competes with H H -LH splitting; Zeem an splitting is the sm aller the larger the H H -LH splitting and vice versa [12]. The appropriate situation can be created in a narrow QW or by application of uni-axial or biaxial stress. O ur sam ples satisfy both of these requirem ents so that we obtain a huge H H -LH splitting, as can be seen in the band pro le in Fig. 2(b), resulting in a vanishingly sm all Zeem an splitting in a eld B_k . This explains why we do not observe a Zeem an splitting in Fig. 5.

In the discussion of F ig. 1 only the isotropic part of the bulk Zeem an term was taken into account [11, 12]. This is the dom inant term. The anisotropic part is typically two orders of magnitude smaller than the isotropic part and the calculations predict for our structure that it gives rise to a linear splitting with $E_{\rm H\,H}^{\ k}$ 0:18 m eV at $B_{\rm k}$ = 18 T. Such a small splitting cannot be resolved in our experiment due to the width of the conductance peaks.

It corresponds to $g_{H\,H}^{\kappa}$ 0:17 which is alm ost two orders of magnitude smaller than $g_{H\,H}^2$ = 6:3

In rare cases of conductance peaks we see a slightly di erent behavior. In Fig. 5 two conductance m axim a at + 10 m V and 10 m V indicate a sm all nonlinear splitting above 10 T. If H H-LH coupling is taken into account, we get a splitting cubic in B_k and inversely proportional to the HH-LH splitting, $E_Z / B_k^3 = E_{HH} E_{LH} j$ (Ref. [12]). For a fully strained system [Fig.2(b)] the calculated splitting due to this term is even smaller than the splitting due to the anisotropic Zeem an term . However, it is conceivable that the levels showing a splitting nonlinear in B_k are related to shallow acceptors situated in sam ple regions of slightly relaxed strain (e.g., close to m is t dislocations). In these regions the HH-LH splitting is thus reduced and the cubic Zeem an splitting increases for these levels. This can explain why a nonlinear splitting is observable for the two conductance peaks at 10 mV, but not for the majority of the conductance resonances which are due to impurities in highly strained regions.

In conclusion, we have perform ed a detailed study of Zeem an splitting of shallow acceptor levels in a thin Si/Ge/Si quantum well, by using resonant tunneling spectroscopy. In a magnetic eld orientated perpendicular to the layer a large linear Zeem an splitting can be observed for magnetic elds up to 18 T. In an in-plane magnetic eld the Zeem an splitting is suppressed. The giant anisotropy of the Zeem an splitting is a consequence of the huge heavy hole-light hole splitting produced by a large biaxial strain and a strong quantum con nem ent in the narrow G e quantum well. It opens a new way to g-factor engineering for spintronics and quantum com puting.

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